SCAS210A - MAY 1987 - REVISED APRIL 1996

14 2A4

13 20E

DB, DW, OR NT PACKAGE Inputs Are TTL-Voltage Compatible (TOP VIEW) Flow-Through Architecture Optimizes **PCB Layout** 24 1 10E 1Y1 Center-Pin V_{CC} and GND Configurations 1Y2 **∏**2 23 1A1 **Minimize High-Speed Switching Noise** 1Y3 **∏**3 22 1 1A2 **EPIC**™ (Enhanced-Performance Implanted 21 1 1A3 1Y4 [CMOS) 1-µm Process GND II 5 20 1 1A4 19 V_{CC} 500-mA Typical Latch-Up Immunity at GND ∏6 18**∏** V_{CC} GND [GND I 17 1 2A1 **Package Options Include Plastic** 2Y1 **∏**9 16 2A2 Small-Outline (DW) and Shrink 2Y2 110 15 2A3 Small-Outline (DB) Packages, and Standard

description

Plastic 300-mil DIPs (NT)

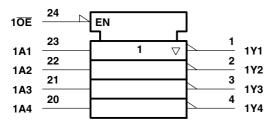
This octal buffer or line driver is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. This device provides inverting outputs and symmetrical active-low output-enable (OE) inputs. This device features high fan-out and improved fan-in.

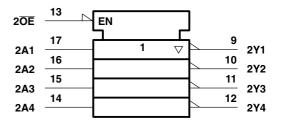
The 74ACT11240 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE (each buffer)

INPL	JTS	OUTPUT
ŌĒ	Α	Υ
L	Н	L
L	L	Н
Н	Χ	Z

logic symbol[†]





2Y3 ∏ 11

2Y4 🛚 12



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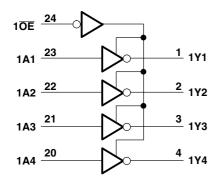
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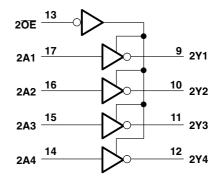


[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	–0.5 V to 6 V
Input voltage range, V _I (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Output voltage range, V _O (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±200 mA
Maximum power dissipation at T _A = 55°C (in still air) (see Note 2): DB package	0.65 W
DW package	1.7 W
NT package	1.3 W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the NT package, which has a trace length of zero.

recommended operating conditions

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	4.5	5	5.5	V
V _{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			8.0	V
VI	Input voltage	0		V_{CC}	V
Vo	Output voltage	0		V_{CC}	V
I _{OH}	High-level output current			-24	mA
I _{OL}	Low-level output current			24	mA
Δt/Δν	Input transition rise or fall rate	0		10	ns/V
T _A	Operating free-air temperature	-40		85	°C



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		T	_A = 25°C	;			
PARAMETER	TEST CONDITIONS	v _{cc}	MIN	TYP	MAX	MIN	MAX	UNIT
	- FO. A	4.5 V	4.4			4.4		
	$I_{OH} = -50 \mu A$	5.5 V	5.4			5.4		
V _{OH}	04 mA	4.5 V	3.94			3.8		V
	$I_{OH} = -24 \text{ mA}$	5.5 V	4.94			4.8		
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85		
	- FO A	4.5 V			0.1		0.1	
	$I_{OL} = 50 \mu A$	5.5 V			0.1		0.1	
V _{OL}	04 4				0.36		0.44	V
	I _{OL} = 24 mA	5.5 V			0.36		0.44	
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65	
l _{OZ}	$V_O = V_{CC}$ or GND	5.5 V			±0.5		±5	μΑ
I _I	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1	μΑ
I _{CC}	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μΑ
Δ l _{CC} ‡	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V		•	0.9		1	mA
C _i	$V_I = V_{CC}$ or GND	5 V		4				pF
Co	$V_I = V_{CC}$ or GND	5 V		10				pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted)

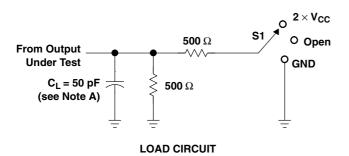
DADAMETED	FROM	то	T,	_A = 25°C	;	MIN	MAY	
PARAMETER	AMETER (INPUT) (OUTPUT)		MIN	TYP	MAX	IVIIN	MAX	UNIT
t _{PLH}		V	1.5	6.5	9.9	1.5	10.6	
t _{PHL}	A	Y	1.5	6	8	1.5	8.7	ns
t _{PZH}	OF.	V	1.5	7.5	11.7	1.5	12.5	
t _{PZL}	ŌĒ	Y	1.5	7.3	11.5	1.5	12.3	ns
t _{PHZ}	- OE	V	1.5	7.3	9.4	1.5	10	
t _{PLZ}] UE	Į , r	1.5	7.9	10.3	1.5	10.8	ns

operating characteristics, V_{CC} = 5 V, T_A = 25°C

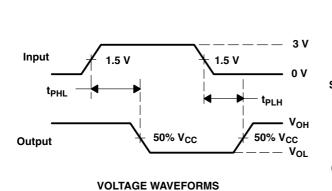
PARAMETER				TEST CONDITIONS		
	Outputs enabled		0 50 - 5	4 4 4 4 4 4	47	
C_{pd}	Power dissipation capacitance per buffer	Outputs disabled	$C_L = 50 \text{ pF},$	f = 1 MHz	13	pF

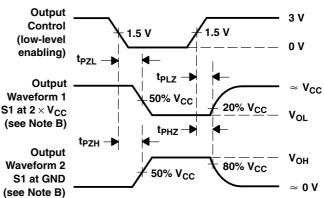
[‡] This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

PARAMETER MEASUREMENT INFORMATION



TEST	S1
t _{PLH} /t _{PHL}	Open
t_{PLZ}/t_{PZL}	$2\times\mathbf{V_{CC}}$
t _{PHZ} /t _{PZH}	GND





VOLTAGE WAVEFORMS

NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \ \Omega$, $t_r = 3 \ ns$, $t_f = 3 \ ns$.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



11-Nov-2025

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
74ACT11240DW	Active	Production	SOIC (DW) 24	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ACT11240
74ACT11240DW.A	Active	Production	SOIC (DW) 24	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ACT11240

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

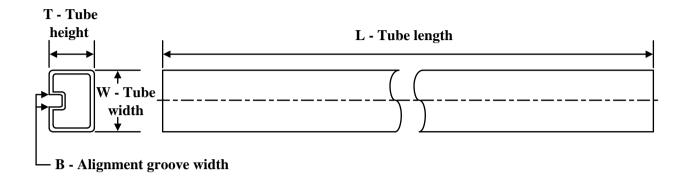
⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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TUBE

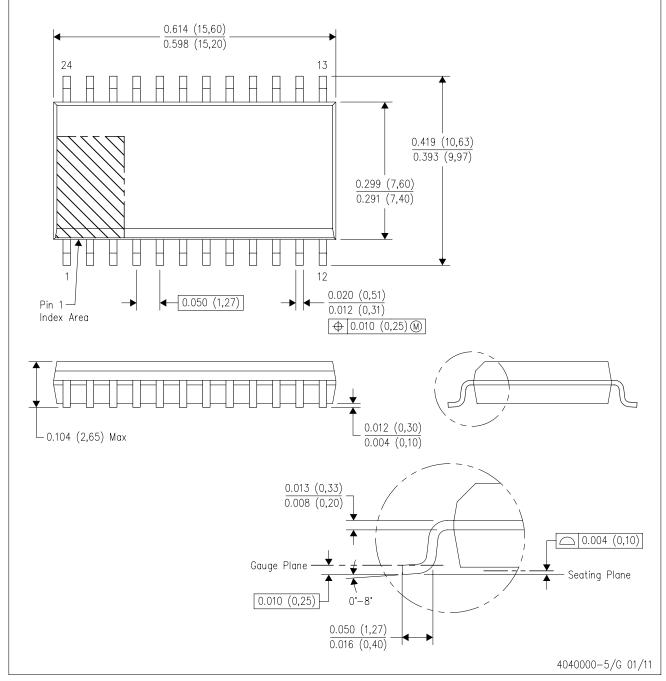


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
74ACT11240DW	DW	SOIC	24	25	506.98	12.7	4826	6.6
74ACT11240DW.A	DW	SOIC	24	25	506.98	12.7	4826	6.6

DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



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